

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10582503	IMANAKA ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
	ALEXANDER C WITKOWSKI	2853

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
347	9, 12, 17, 19, 43, 48, 49, 50, 54, 56, 58, 59, 65.	01/12/2009	ACW
358	296	01/12/2009	ACW
422	100	01/12/2009	ACW
439	181	01/12/2009	ACW

<b>SEARCH NOTES</b>			
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>	
Stephen D. Meier, Supervisory Patent Examiner.	09/24/2008	ACW	
Limited classification search: 347/ 62, 64	09/24/2008	ACW	
Text search. See search history.	09/24/2008	ACW	
Julian Huffman, Primary Examiner	01/12/2009	ACW	
Juanita Stevens, Primary Examiner	01/15/2009	ACW	
Limited classification search: 347/ 9, 12, 17, 19, 43, 48, 49, 50, 54, 56, 58, 59, 65; 358/ 296; 422/ 100; 439/ 181.	01/12/2009	ACW	
Text search. See search history.	01/12/2009	ACW	

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
347	9, 12, 17, 19, 43, 48, 49, 50, 54, 56, 58, 59, 65.	01/19/2009	ACW

/A. C. W./ Examiner Art Unit 2853	
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